TOSHIBA 2SC5066FT

### TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL PLANAR TYPE

# 2 S C 5 0 6 6 F T

VHF~UHF BAND LOW NOISE AMPLIFIER APPLICATIONS

- Low Noise Figure, High Gain.
- NF = 1.1dB,  $|S_{21e}|^2 = 12dB$  (f=1GHz)

#### MAXIMUM RATINGS (Ta = 25°C)

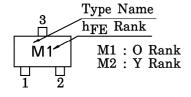
CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	$v_{CBO}$	20	V
Collector-Emitter Voltage	$v_{CEO}$	12	V
Emitter-Base Voltage	$V_{ m EBO}$	3	V
Base Current	$I_{\mathbf{B}}$	15	mA
Collector Current	$I_{\mathbf{C}}$	30	mA
Collector Power Dissipation	PC	100	mW
Junction Temperature	$T_{j}$	125	°C
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~125	°C

## $1.2 \pm 0.05$ $0.8 \pm 0.05$ 0.22 0.32 0.9 ± 0.1 3 BASE **EMITTER** TESM COLLECTOR **JEDEC** EIAJ TOSHIBA 2-1B1A

Unit in mm

Weight: 0.0022g

### **MARKING**



### MICROWAVE CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Transition Frequency	${ m f_T}$	$V_{CE}=5V$ , $I_{C}=10$ mA	5	7	_	GHz
Incortion (fain	$ S_{21e} ^2$ (1)	$V_{CE} = 5V, I_{C} = 10mA, f = 500MHz$	_	17	_	dB
	$ S_{21e} ^2$ (2)	$V_{CE}=5V$ , $I_{C}=10$ mA, $f=1$ GHz	8.5	12	_	
I Noise Figure	NF (1)	$V_{CE}=5V$ , $I_{C}=3mA$ , $f=500MHz$	_	1	_	dB
	NF (2)	$V_{CE}=5V$ , $I_{C}=3mA$ , $f=1GHz$	_	1.1	2.0	иь

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### ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	$I_{CBO}$	$V_{CB} = 10V, I_{E} = 0$		_	1	$\mu$ A
Emitter Cut-off Current	$I_{ m EBO}$	$V_{EB}=1V, I_{C}=0$	l	_	1	$\mu$ A
DC Current Gain	h <sub>FE</sub> (Note 1)	$V_{CE}=5V, I_{C}=10mA$	80	_	240	_
Output Capacitance	$C_{\mathbf{ob}}$	$V_{CB}$ =5V, $I_E$ =0, f=1MHz		0.7	_	рF
Reverse Transfer Capacitance	$\mathrm{C_{re}}$	(Note 2)	_	0.45	0.9	рF

(Note 1): hFE Classification  $O:80{\sim}160,\ Y:120{\sim}240$  (Note 2):  $C_{re}$  is measured by 3 terminal method with capacitance bridge.